



www.nemko.com

Amendment to Test Report		
This Amendment is valid only together with the main Test Report		
Report No :		
Main Report No :		
Date of issue:	January 26, 2015	
Total number of pages::	5	
Applicant's Name:	Power Integrations, Inc.	
Address:	5245 Hellyer Avenue, San Jose, CA 95138, U.S.A.	
Test specification		
Standard: :	IEC 60065:2001 (Seventh Edition) + A1:2005 + A2:2010 with CTL Decision, DSH 1080	
Test procedure::	CB scheme	
Non-standard test method: :	N/A	
Copyright © 2010 Worldwide System for Conformity Testing and Certification of Electrotechnical Equipment and Components (IECEE), Geneva, Switzerland. All rights reserved.		
This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.		
If this Test Report Form is used by nor Scheme procedure shall be removed.	IECEE members, the IECEE/IEC logo and the reference to the CB	
This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.		
Test item description::	IC including capacitor discharge function (ICX)	
Trade Mark: :	CAPZero	
Manufacturer:	Power Integrations, Inc.	
Model/Type reference: :	CAP002DG; CAP003DG; CAP004DG; CAP005DG; CAP006DG; CAP007DG; CAP008DG; CAP009DG; CAP012DG; CAP013DG; CAP014DG; CAP015DG; CAP016DG; CAP017DG; CAP018DG; CAP019DG; SC1143; CAP200DG	
Ratings:	230V AC nominal (tested for 85-265V AC, 47-63Hz)	

Nemko Rev. 2013-10



Testing procedure and testing location:				
$\square$	CB Testing Laboratory:	Nemko A/S		
Testir	ng location/ address	Gaustadalléen 30, NO -	0373 Oslo, Norway	
	Associated CB Laboratory:			
Testir	ng location/ address:			
	Tested by (name + signature) :	Ole Morten Aaslund	Ole Morten Aaslind	
	Approved by (name + signature) :	Hans-Eirik Lie	Howerton	
	Testing procedure: TMP			
Testir	ng location/ address			
	Tested by (name + signature) :			
	Approved by (name + signature) :			
	Testing procedure: WMT			
Testir	ng location/ address:			
	Tested by (name + signature) :			
	Witnessed by (name + signature). :			
	Approved by (name + signature) :			
	Testing procedure: SMT			
Testir	ng location/ address:			
	Tested by (name + signature) :			
	Approved by (name + signature) :			
	Supervised by (name + signature) :			
	Testing procedure: RMT			
Testir	ng location/ address:			
	Tested by (name + signature) :			
	Approved by (name + signature) :			
	Supervised by (name + signature) :			



## List of Attachments (including a total number of pages in each attachment):

N/A

Summary of testing:	
N/A	
Tests performed (name of test and test clause):	Testing location:
Summary of compliance with National Differences	5
N/A	

## Copy of marking plate

The artwork below may be only a draft. The use of certification marks on a product must be authorized by the respective NCBs that own these marks.

Refer main report.

Calibration	All instruments used in the tests given in this test report are calibrated and traceable to national or international standards. Further information about traceability will be given on request.
Measurement uncertainty	Measurement uncertainties are calculated for all instruments and instrument set-ups given in this report. Calculations are based on the principles given in the standard EA-4/02 (Dec. 1999), IEC Guide 115:2007 and other relevant internal Nemko-procedures. Further information about measurement uncertainties will be given on request.
Evaluation of results	If not explicitly stated otherwise in the standard, the test is passed if the measured value is equal to or below (above) the limit line, regardless of the measurement uncertainty. If the measured value is above (below) the limit line, the test is not passed - ref IEC Guide 115:2007. The instrumentation accuracy is within limits agreed by IECEE-CTL.



Possible test case verdicts:			
- test case does not apply to the test object :	Not Applicable (N/A)		
- test object does meet the requirement: :	Pass (P)		
- test object does not meet the requirement: :	Fail (F)		
Testing:			
Date of receipt of test item:	N/A		
Date(s) of performance of tests:	N/A		
General remarks:			
The test results presented in this report relate only to the This report shall not be reproduced, except in full, witho "(see Enclosure #)" refers to additional information app "(see appended table)" refers to a table appended to the	ut the written approval of the Issuing testing laboratory. bended to the report.		
Throughout this report a $\Box$ comma / $igtriangleq$ point is used as the decimal separator.			
Manufacturer's Declaration per sub-clause 6.2.5 of IECEE 02:			
The application for obtaining a CB Test Certificate includes more than one factory location and a declaration from the Manufacturer stating that the sample(s) submitted for evaluation is (are) representative of the products from each factory has been provided	<ul> <li>☐ Yes</li> <li>☑ Not applicable</li> </ul>		
When differences exist; they shall be identified in the General product information section.			
Name and address of factory (ies):	Millenium Microtech Shanghai No. 351 Guo Shou Jing Rd., Z.J. Hi Tech Park Pudong New Area, Shanghai, 201203 CHINA		
General product information:			
The update concerned in this amendment report cove			



Project history:		
Nemko Report/ Order No.:	Modification to the appliances:	Changes/ Modifications in clause(s):
246847	Main Test Report	N/A
247609	Adding of voltage and frequency range; 85-265V AC, 47-63Hz. Note that DSH 1080 only covers Installation Category II (2.5kV transients), and end products using the ICX covered by this report must follow the same Installation Category.	Summary of testing, General product information, 9.1.1.1 and 9.1.6
270270	Introduction of different minimum and maximum X-capacitance and resistance values: X-capacitance: Min. 100nF, max. 6μF Resistance: Min. 142kΩ, max. 7.5MΩ Refer also General product information.	Summary of testing, General product information, 9.1.1.1 and 9.1.6
277779	Addition of a new model CAP200DG. The new model is identical to model SC1143 except for model name. No additional testing required.	5.1

5.1	a) Identification, maker:	CAPZero	Р
	b) Model number or type reference:	CAP002DG; CAP003DG; CAP004DG; CAP005DG; CAP006DG; CAP007DG; CAP008DG; CAP009DG; CAP012DG; CAP013DG; CAP014DG; CAP015DG; CAP016DG; CAP017DG; CAP018DG; CAP019DG; SC1143; CAP200DG	Ρ